

MODEL PSF EFECTS OF PILE-UP ON 3D

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Index:

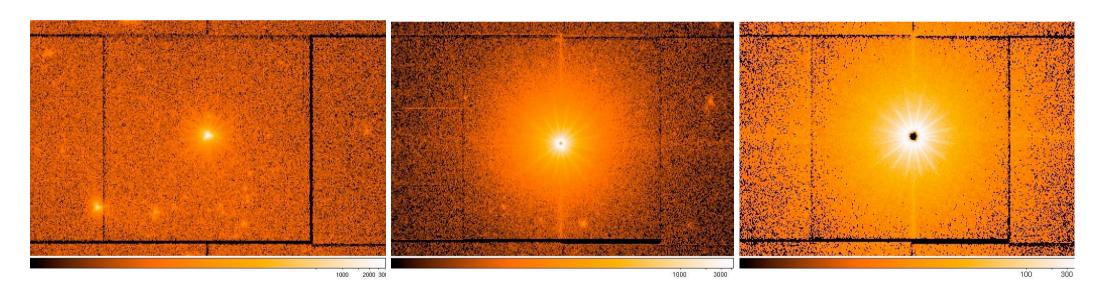
- Aim of the project.
- Selection of the observations.
- Selection of point sources.
- Determination of the counts per second.
- Determination of pile-up.
- Next steps.





Aim of the project:

- Pile-up: Arrival of two or more photons within the readout time of the detectors.
- For very bright sources there is a considerable amount of pile-up.
- The centre of the PSF (Point Spread Function) gets distorted:



Clean PSF.

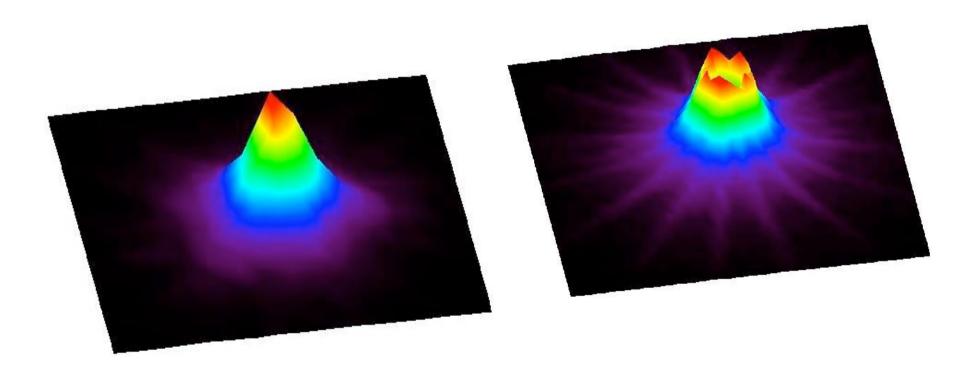
Loss of counts at the centre of the PSF.





Aim of the project:

Finally a 3D model of the PSF will be created:



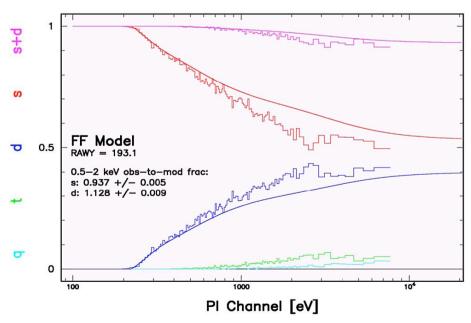




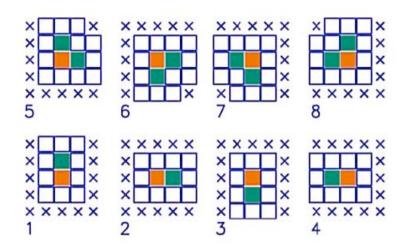
What is pile-up?

Pattern pile-up: Two or more photons arriving next to each other in the same readout time.

Photon pile-up: One single photon causes multiple pixel activation



SAS task Fnathlot outnut



Consequences:

- Less counts at the PSF centre.
- Shifts the spectrum towards higher energies.





Selection of observations:

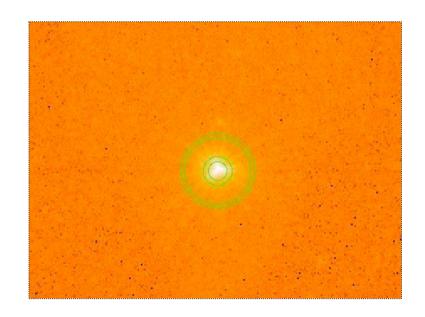
- Distinguish point sources:
 - Observation Modes
 - Filters

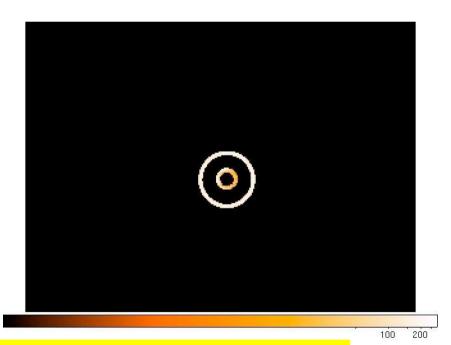




Selection of point sources:

In order to **automatically** determine if an observation is of an extended source or a point source the **counts per second of two annuli around the source** were calculated and then the **ratio** of these two count-rates.





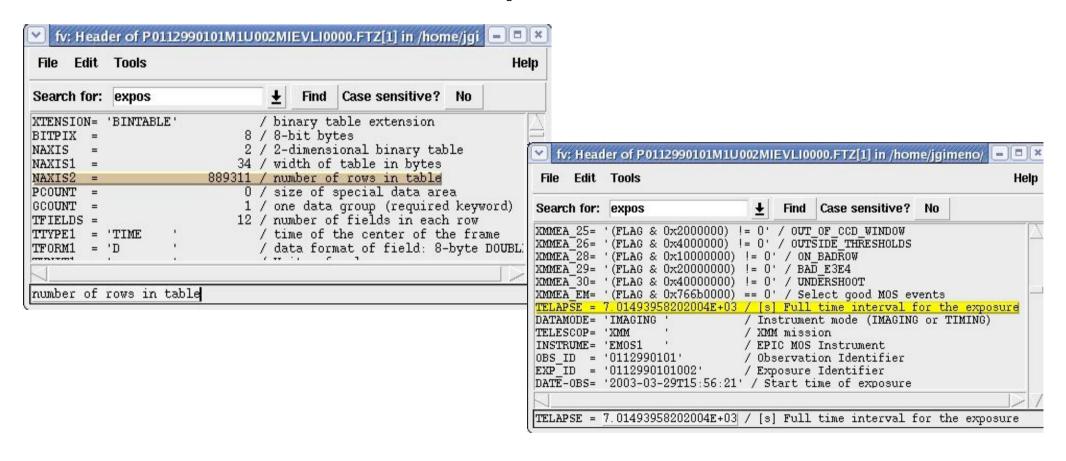
Point source: ratio=[5%, 15%]

Extended source: >X%





Determination of counts per second:



Once the number of events registered by the detectors and the exposure time is known, the count rate is determined.





Source coordinates determination:

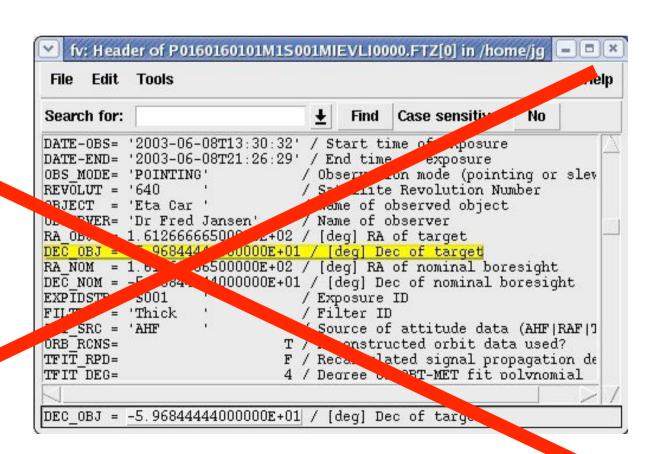
Annuli extraction needs — PSF centre, position of the source in the detector.

First Attempt:

SAS task sky2det

Header sky coordinates

Detector coordinate







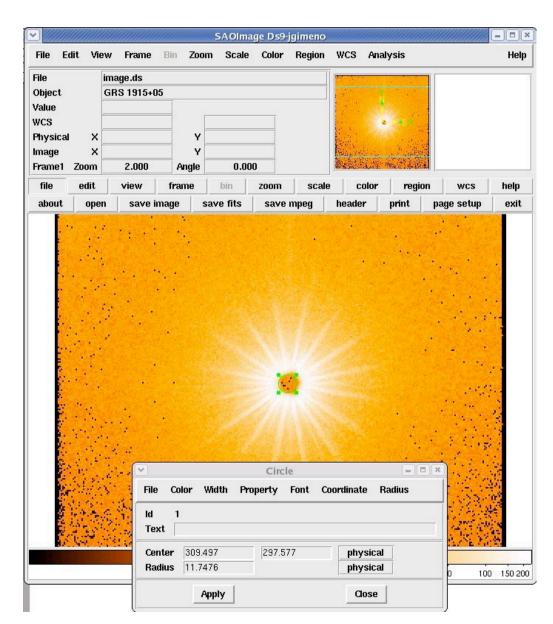
Chosen Solution:

+ Work on the Generated Image

Find the centre of mass using IDL software

$$\langle x \rangle = \frac{\int I(x, y) x \, dx \, dy}{\int I(x, y) \, dx \, dy} = \frac{\sum I_{ij} i}{\sum I_{ij}}$$

$$\langle y \rangle = \frac{\int I(x,y)y \, dx \, dy}{\int I(x,y) \, dx \, dy} = \frac{\sum I_{ij} \, j}{\sum I_{ij}}$$





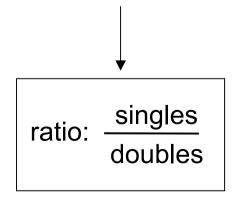


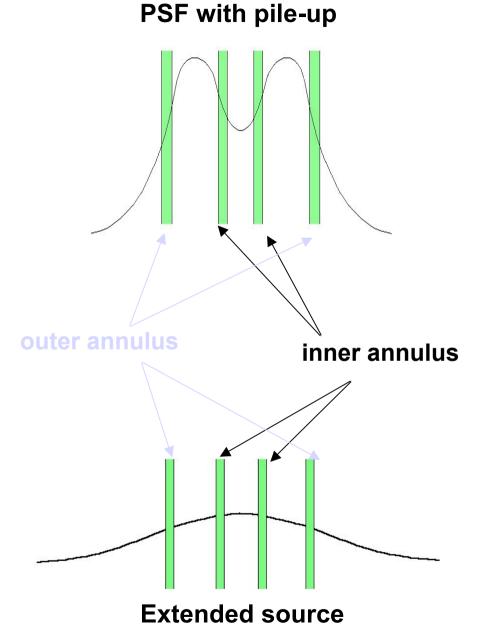
Chosen Solution:

Strong pile-up case

Similar ratio as in the extended source case:

Avoid the identification of extended sources as strong pile-up observations

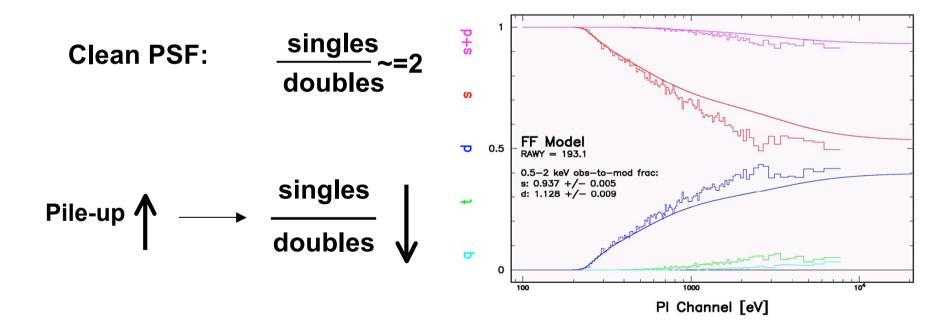






Determination of pile-up:

Ratio between the single events and double events in energy band of 1keV to 1.8keV. (TBD)





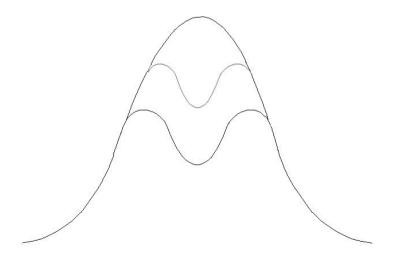


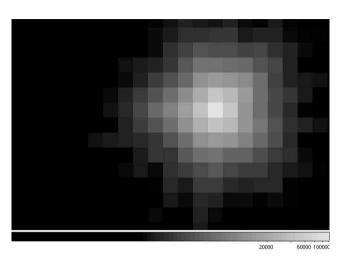
Next steps:

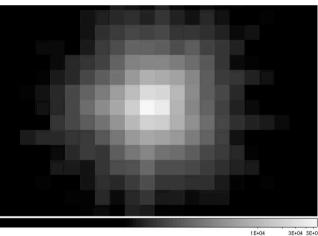
Sum up observations with clean PSF:

- Change position of source.
- Superposition.
- Normalize.

Summing up observations in different pile-ups and comparison with clean PSF:







MOS camera examples.





Questions?

